# International Rectifier

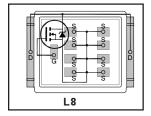
#### **AUTOMOTIVE GRADE**

# AUIRF7759L2TR AUIRF7759L2TR1

- Advanced Process Technology
- Optimized for Automotive Motor Drive, DC-DC and other Heavy Load Applications
- Exceptionally Small Footprint and Low Profile
- High Power Density
- Low Parasitic Parameters
- Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Capability for Robustness and Reliability
- · Lead Free, RoHS Compliant and Halogen Free
- Automotive Qualified \*

Automotive DirectFET® Power MOSFET @

V <sub>(BR)DSS</sub>	75V
R <sub>DS(on)</sub> typ.	1.8m $\Omega$
max.	<b>2.3m</b> $Ω$
I <sub>D (Silicon Limited)</sub>	160A
$Q_g$	200nC





Applicable DirectFET® Outline and Substrate Outline ①

SB	SC		M2	М4	L4	L6	L8	

### **Description**

The AUIRF7759L2TR(1) combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET® packaging to achieve the lowest on-state resistance in a package that has the footprint of a DPak (TO-252AA) and only 0.7 mm profile. The DirectFET® package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET® package allows dual sided cooling to maximize thermal transfer in automotive power systems.

This HEXFET® Power MOSFET is designed for applications where efficiency and power density are essential. The advanced DirectFET® packaging platform coupled with the latest silicon technology allows the AUIRF7759L2TR(1) to offer substantial system level savings and performance improvement specifically in motor drive, high frequency DC-DC and other heavy load applications on ICE, HEV and EV platforms. This MOSFET utilizes the latest processing techniques to achieve low on-resistance and low Qg per silicon area. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for high current automotive applications.

	Parameter	Max.	Units		
V <sub>DS</sub>	Drain-to-Source Voltage	75	V		
$V_{GS}$	Gate-to-Source Voltage	±20			
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) 4	160			
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) @	113	Ī		
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)3	26	Α		
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited) @	375	<u>†</u> ^		
I <sub>DM</sub>	Pulsed Drain Current ®	640	†		
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation ④	125			
P <sub>D</sub> @T <sub>C</sub> = 100°C	Power Dissipation ④	63	W		
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation ①	3.3	Ī		
E <sub>AS</sub>	Single Pulse Avalanche Energy ®	257	mJ		
I <sub>AR</sub>	Avalanche Current ⑤	Coo Fig 10a 10b 16 17	Α		
E <sub>AR</sub>	Repetitive Avalanche Energy <sup>⑤</sup>	See Fig.18a, 18b, 16, 17	mJ		
T <sub>P</sub>	Peak Soldering Temperature	270			
TJ	Operating Junction and	-55 to + 175	°C		
T <sub>STG</sub>	Storage Temperature Range				

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient ③		45	
$R_{\theta JA}$	Junction-to-Ambient ®	12.5		
$R_{\theta JA}$	Junction-to-Ambient ®	20		°C/W
$R_{\theta J ext{-Can}}$	Junction-to-Can ⊕®		1.2	]
$R_{\theta J\text{-PCB}}$	Junction-to-PCB Mounted		0.5	
	Linear Derating Factor <sup>4</sup>	0	.83	W/°C

HEXFET® is a registered trademark of International Rectifier.

### Static Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)

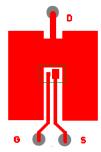
	Parameter	Min.	Тур.	Max.	Units	Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	75			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.02	_	V/°C	Reference to 25°C, I <sub>D</sub> = 2mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		1.8	2.3	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 96A ⑦
$V_{GS(th)}$	Gate Threshold Voltage	2.0	3.0	4.0	V	V - V I - 250uA
$\Delta V_{GS(th)}/\Delta T_{J}$	Gate Threshold Voltage Coefficient		-11		mV/°C	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
gfs	Forward Transconductance	74			S	$V_{DS} = 25V, I_{D} = 96A$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20		$V_{DS} = 75V, V_{GS} = 0V$
				250	μA	$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100	] ''A	V <sub>GS</sub> = -20V

### Dynamic Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)

•	U \				,	
$Q_g$	Total Gate Charge		200	300		
Q <sub>gs1</sub>	Pre-Vth Gate-to-Source Charge		37			$V_{DS} = 38V$
$Q_{gs2}$	Post-Vth Gate-to-Source Charge		11		nC	$V_{GS} = 10V$
$Q_gd$	Gate-to-Drain Charge		62	93	110	$I_D = 96A$
$Q_godr$	Gate Charge Overdrive		91			See Fig. 9
$Q_{sw}$	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )		73			
Q <sub>oss</sub>	Output Charge		60		nC	$V_{DS} = 16V$ , $V_{GS} = 0V$
$R_G$	Gate Resistance		1.1		Ω	
t <sub>d(on)</sub>	Turn-On Delay Time		18			$V_{DD} = 38V, V_{GS} = 10V$ ⑦
t <sub>r</sub>	Rise Time		37		ns	$I_D = 96A$
t <sub>d(off)</sub>	Turn-Off Delay Time	_	80		115	$R_G=1.8\Omega$
t <sub>f</sub>	Fall Time		33	_		
C <sub>iss</sub>	Input Capacitance		12222			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		1465			$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		609		pF	f = 1.0MHz
C <sub>oss</sub>	Output Capacitance		7457			$V_{GS} = 0V, V_{DS} = 1.0V, f=1.0MHz$
C <sub>oss</sub>	Output Capacitance		955			$V_{GS} = 0V, V_{DS} = 60V, f=1.0MHz$

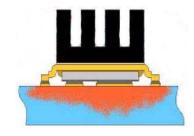
# Diode Characteristics @ T<sub>J</sub> = 25°C (unless otherwise stated)

	•			-		
	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current			160		MOSFET symbol
	(Body Diode)			160	١,	showing the
I <sub>SM</sub>	Pulsed Source Current			640	Α	integral reverse
	(Body Diode) ⑤			040		p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$ , $I_S = 96A$ , $V_{GS} = 0V$ ⑦
t <sub>rr</sub>	Reverse Recovery Time		64	96	ns	$T_J = 25^{\circ}C$ , $I_F = 96A$ , $V_{DD} = 38V$
Q <sub>rr</sub>	Reverse Recovery Charge		150	225	nC	di/dt = 100A/µs ⑦



③ Surface mounted on 1 in. square Cu (still air).

Notes ① through ⑩ are on page 10



Mounted to a PCB with small clip heatsink (still air)



 Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)

# Qualification Information<sup>†</sup>

			Automotive		
		(per AEC-Q101) <sup>††</sup>			
Qualification Level			art number(s) passed Automotive qualification. IR's umer qualification level is granted by extension of e level.		
Moisture Sensitivity L	_evel	LARGE-CAN	MSL1		
	Machine Model	Class M4 (+/- 800V)			
		(per AEC-Q101-002)			
	Human Body Model		Class H2 (+/- 6000V)		
ESD			(per AEC-Q101-001)		
Charged Device			N/A		
	Model	(per AEC-Q101-005)			
RoHS Compliant Yes			Yes		

- † Qualification standards can be found at International Rectifier's web site: http://www.irf.com/
- †† Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

www.irf.com 3

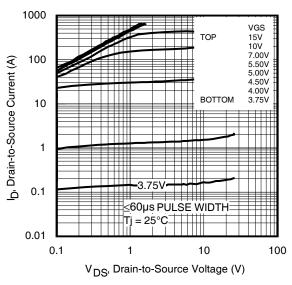


Fig 1. Typical Output Characteristics

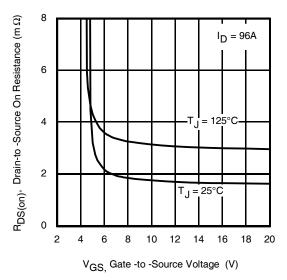


Fig 3. Typical On-Resistance vs. Gate Voltage

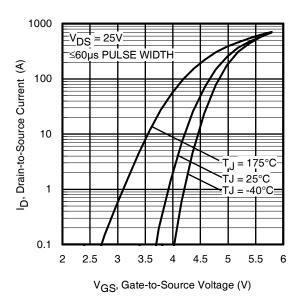


Fig 5. Typical Transfer Characteristics

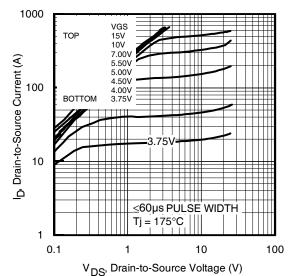


Fig 2. Typical Output Characteristics

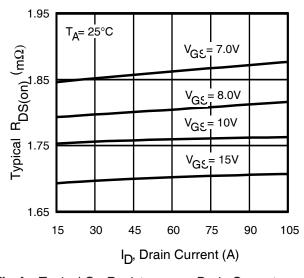


Fig 4. Typical On-Resistance vs. Drain Current

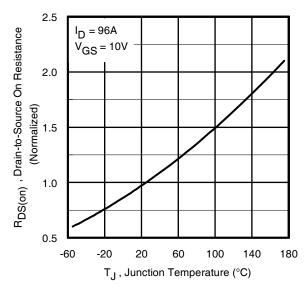


Fig 6. Normalized On-Resistance vs. Temperature www.irf.com

### International

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**Fig 7.** Typical Threshold Voltage vs. Junction Temperature

T<sub>.1</sub>, Temperature ( °C )

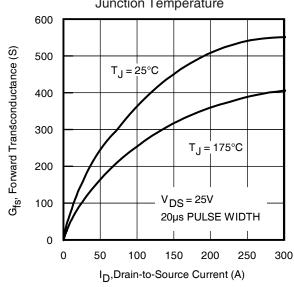
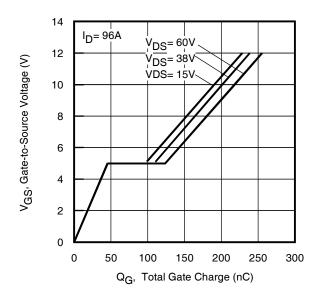


Fig 9. Typical Forward Transconductance vs. Drain Current



**Fig.11** Typical Gate Charge vs.Gate-to-Source Voltage www.irf.com

# AUIRF7759L2TR/TR1

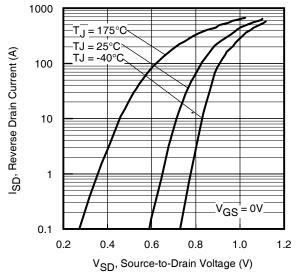


Fig 8. Typical Source-Drain Diode Forward Voltage

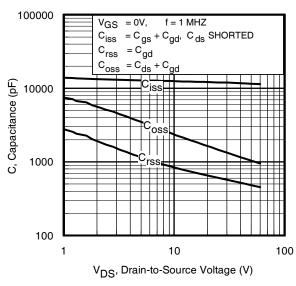


Fig 10. Typical Capacitance vs.Drain-to-Source Voltage

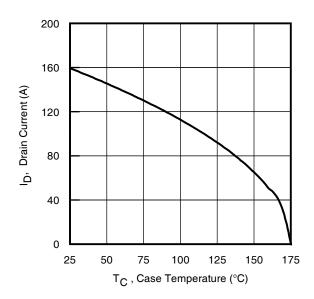
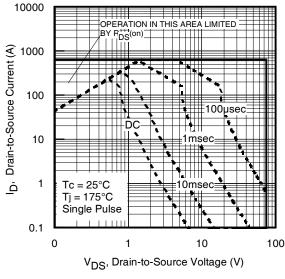


Fig 12. Maximum Drain Current vs. Case Temperature



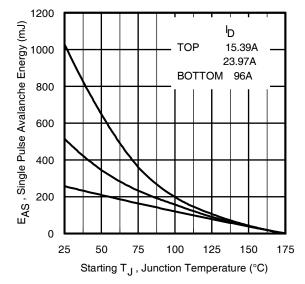


Fig 13. Maximum Safe Operating Area

Fig 14. Maximum Avalanche Energy vs. Temperature

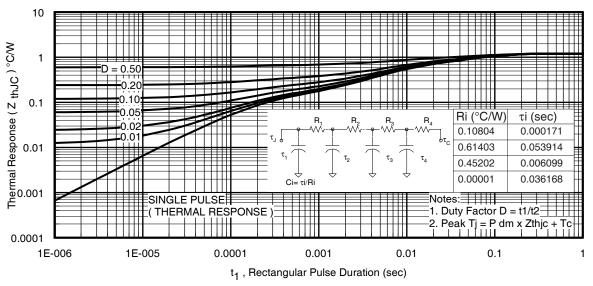


Fig 15. Maximum Effective Transient Thermal Impedance, Junction-to-Case

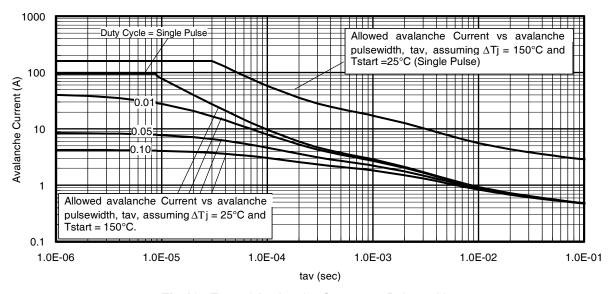


Fig 16. Typical Avalanche Current vs. Pulsewidth

# International TOR Rectifier

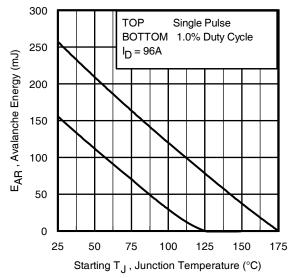


Fig 17. Maximum Avalanche Energy vs. Temperature

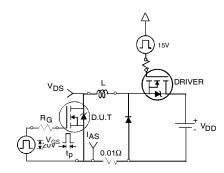


Fig 18a. Unclamped Inductive Test Circuit

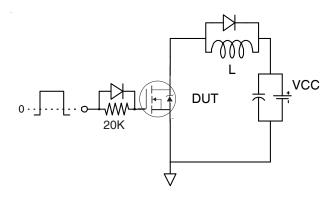


Fig 19a. Gate Charge Test Circuit

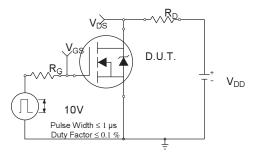


Fig 20a. Switching Time Test Circuit

### AUIRF7759L2TR/TR1

Notes on Repetitive Avalanche Curves , Figures 14, 17: (For further info, see AN-1005 at www.irf.com)

- Avalanche failures assumption:
   Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>jmax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long  $asT_{jmax}$  is not exceeded.
- Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).

t<sub>av =</sub> Average time in avalanche.

D = Duty cycle in avalanche =  $t_{av} \cdot f$ 

 $Z_{th,IC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; ( \; 1.3 \cdot BV \cdot I_{av}) = \triangle T/ \; Z_{thJC} \\ I_{av} &= 2\triangle T/ \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

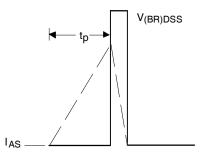


Fig 18b. Unclamped Inductive Waveforms

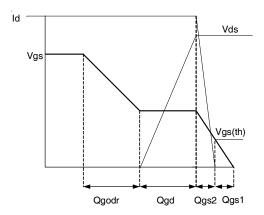


Fig 19b. Gate Charge Waveform

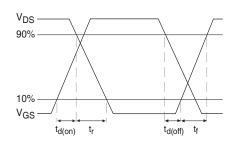


Fig 20b. Switching Time Waveforms

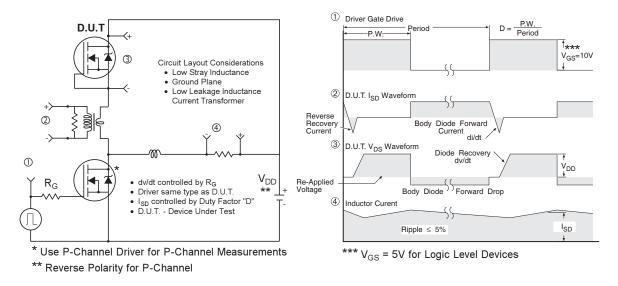
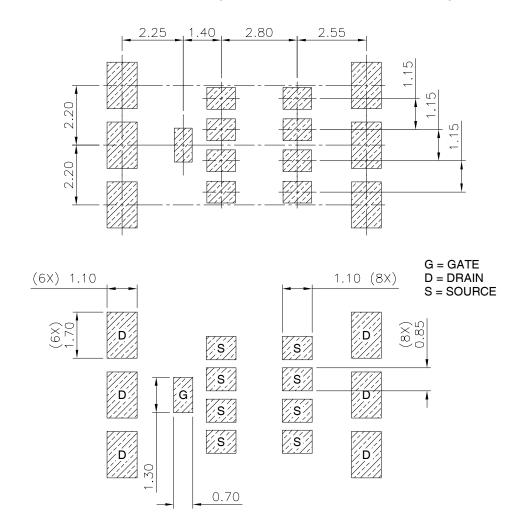


Fig 21. Diode Reverse Recovery Test Circuit for HEXFET® Power MOSFETs

### Automotive DirectFET® Board Footprint, L8 (Large Size Can).

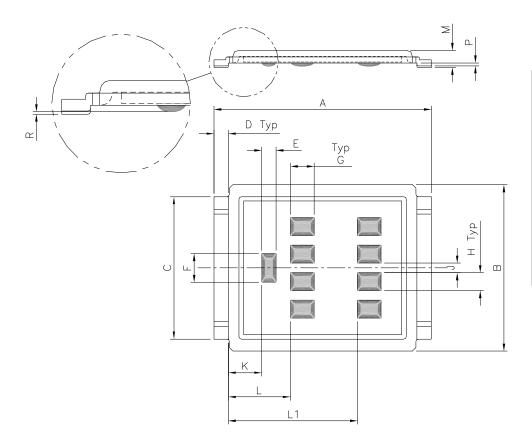
Please see AN-1035 for DirectFET® assembly details and stencil and substrate design recommendations



Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package">http://www.irf.com/package</a>

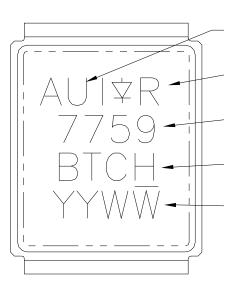
### Automotive DirectFET® Outline Dimension, L8 Outline (LargeSize Can).

Please see AN-1035 for DirectFET® assembly details and stencil and substrate design recommendations



	DIMENSIONS									
	MET	RIC	IMPE	RIAL						
CODE	MIN	MAX	MIN	MAX						
Α	9.05	9.15	0.356	0.360						
В	6.85	7.10	0.270	0.280						
С	5.90	6.00	0.232	0.236						
D	0.55	0.65	0.022	0.026						
Е	0.58	0.62	0.023	0.024						
F	1.18	1.22	0.046	0.048						
G	0.98	1.02	0.039	0.040						
Н	0.73	0.77	0.029	0.030						
J	0.38	0.42	0.015	0.017						
K	1.35	1.45	0.053	0.057						
L	2.55	2.65	0.100	0.104						
L1	5.35	5.45	0.211	0.215						
М	0.68	0.74	0.027	0.029						
Р	0.09	0.17	0.003	0.007						
R	0.02	0.08	0.001	0.003						

Automotive DirectFET® Part Marking



"AU" = GATE AND AUTOMOTIVE MARKING

**LOGO** 

PART NUMBER

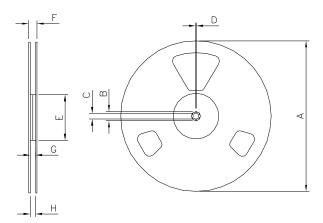
**BATCH NUMBER** 

DATE CODE

Line above the last character of the date code indicates "Lead-Free"

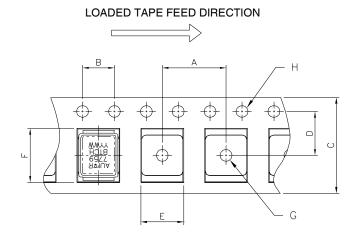


### Automotive DirectFET® Tape & Reel Dimension (Showing component orientation).



NOTE: Controlling dimensions in mm Std reel quantity is 4000 parts. (ordered as AUIRF7759L2TR). For 1000 parts on 7" reel, order AUIRF7759L2TR1

	REEL DIMENSIONS											
ST	ANDARD	OPTION	(QTY 400	TR	1 OPTION	V (QTY 10	00)					
	MET	RIC	IMPE	RIAL	MET	RIC	IMPE	RIAL				
CODE	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX				
Α	330.00	N.C	12.992	N.C	177.80	N.C	7.000	N.C				
В	20.20	N.C	0.795	N.C	20.20	N.C	0.795	N.C				
С	12.80	13.20	0.504	0.520	12.98	13.50	0.331	0.50				
D	1.50	N.C	0.059	N.C	1.50	2.50	0.059	N.C				
E	99.00	100.00	3.900	3.940	62.48	N.C	2.460	N.C				
F	N.C	22.40	N.C	0.880	N.C	N.C	N.C	0.53				
G	16.40	18.40	0.650	0.720	N.C	N.C	N.C	N.C				
Н	15.90	19.40	0.630	0.760	16.00	N.C	0.630	N.C				



NOTE: CONTROLLING DIMENSIONS IN MM

DIMENSIONS									
	MET	TRIC	IMPE	RIAL					
CODE	MIN	MAX	MIN	MAX					
Α	11.90	12.10	4.69	0.476					
В	3.90	4.10	0.154	0.161					
С	15.90	16.30	0.623	0.642					
D	7.40	7.60	0.291	0.299					
Е	7.20	7.40	0.283	0.291					
F	9.90	10.10	0.390	0.398					
G	1.50	N.C	0.059	N.C					
Н	1.50	1.60	0.059	0.063					

Note: For the most current drawing please refer to IR website at http://www.irf.com/package

#### Notes:

- ① Click on this section to link to the appropriate technical paper.
- ② Click on this section to link to the DirectFET® Website.
- ③ Surface mounted on 1 in. square Cu board, steady state.
- $\ \, \mbox{\it \textcircled{4}} \ \mbox{\it T}_{\mbox{\it C}}$  measured with thermocouple mounted to top (Drain) of part.
- ⑤ Repetitive rating; pulse width limited by max. junction temperature.
- © Starting  $T_J = 25^{\circ}C$ , L = 0.056mH,  $R_G = 25\Omega$ ,  $I_{AS} = 96A$ .
- $\bigcirc$  Pulse width  $\leq$  400 $\mu$ s; duty cycle  $\leq$  2%.
- $\ensuremath{\$}$  Used double sided cooling, mounting pad with large heatsink.
- Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- $^{\circ}$  R<sub> $\theta$ </sub> is measured at T<sub>J</sub> of approximately 90°C.

**Ordering Information** 

Base part number	Package Type	Standard	Pack	Complete Part Number
		Form	Quantity	
AUIRF7759L2	DivoctEETO Laves Con	Tape and Reel	4000	AUIRF7759L2TR
AUINF//59L2	DirectFET2 Large Can	Tape and Reel	1000	AUIRF7759L2TR1

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#### **IMPORTANT NOTICE**

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